

Search Notes

Application/Control No.

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Examiner

YONG D. PAK

Applicant(s)/Patent under
Reexamination

SHYUR ET AL.

Art Unit

1652

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
435	201	12/19/2008	YP
435	440	12/19/2008	YP
536	23.2	12/19/2008	YP
STIC: SEQ ID NO:1		12/19/2008	YP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC: seq id no:1	12/19/2008	YP
east (all databases): inventor and text search	12/19/2008	YP
PALM: inventor search	12/19/2008	YP